

Notice of References Cited	Application/Control No. 10/082,112	Applicant(s)/Patent Under Reexamination TANIKAWA ET AL.	
	Examiner Philip B. Tran	Art Unit 2155	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,895,588	05-2005	Ruberg, Alan T.	709/223
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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